

NSM0402AT-LL Top-Inlet Analog Silicon Microphone Specification

Rev 1.0



1. GENERAL DESCRIPTION

NSM0402AT-LL is a Silicon Microphone with analog output and top inlet for sound input. It is a cost-effective alternative to traditional electret condenser microphone (ECM). Provided on tap-and-reel, it is ideally suited for high volume applications. And it can be processed directly to customer's PCB using standard automatic pick-and-place equipment and surface mounted via standard solder reflow equipment.

NSM0402AT-LL is a new Silicon Microphone with Maximum RF protection. It uses a new anti-interference circuit to avoid RF interference. It is great convenience for customers to solve terminal RF interference.

NSM0402AT-LL can be used in (but not limited to) the following applications:

- 1. Portable communication device
- 2. Notebook and desktop
- 3. Headphone and headset accessories

2. ABSOLUTE MAXIMUM RATINGS

Supply voltage: VDD to GND	0.3V~5V
ESD Tolerance	
The Lid Mode	8kV
The I/O Pin Mode	4kV

TEMPERATURE CHARACTERISTICS					
Parameter	Conditions	Min	Тур	Max	Unit
Operating Temperature		-40		+85	°C
Store on Tommersture	Solder on PC board	-40		+105	°C
Storage Temperature	In Tape and Reel	-10		+50	°C

Wuxi NeoMEMS Technologies, Inc.

The above information is the exclusive intellectual property of Wuxi NeoMEMS Technologies, Inc. and shall not be disclosed, distributed or reproduced without permission from Wuxi NeoMEMS Technologies, Inc.



3. ACOUSTIC & ELECTRICAL SPECIFICATIONS

Unless otherwise specified, test conditions are:

Typical specifications are measured at VDD =3V

Input sound pressure $P_{IN} = 94dBSPL@1kHZ$

Test room temperature Ta = 25 °C, Room Humidity = $50 \pm 20\%$

SNR & noise floor measurement is based on 20 - 20 KHz pass band with A-Weighting

Filter applied

PERFORMANCE					
Parameter	Conditions	Min Typ Max		Unit	
Directivity			Omni-I	Direction	al
Sensitivity	$(0.1 \text{ VI}_{\text{c}})$		-42		dDry
Sensitivity Tolerance	@1KHz (0 dB = 1V/Pa)	-1	0	1	dBv
Signal-to-Noise Ratio	@1KHz (0 dB = 1V/Pa)		59		dB
Total Harmonic Distortion (THD) @ 94dB SPL	@1KHz			0.5	%
Max Input Sound Pressure	@1KHz, THD < 10%		125		dBSPL
Power Supply Rejection (PSR)	217Hz,100mVpp square wave		-84		dB
	INPUT CHARACTERISTICS				
Power supply Voltage		1.6		3.6	V
Sensitivity Loss Across Power Supply Voltage	Change in sensitivity from 1.6V to 3.6V power supply voltage	No change of		dB	
Total Operation Current	1.6V-3.6V power supply voltage	78		uA	
	OUTPUT CHARACTERISTICS				
Output Impedance	@1KHz (0 dB = 1 V/Pa)			200	Ω

Wuxi NeoMEMS Technologies, Inc.

The above information is the exclusive intellectual property of Wuxi NeoMEMS Technologies, Inc. and shall not be disclosed, distributed or reproduced without permission from Wuxi NeoMEMS Technologies, Inc.



4. FREQUENCY RESPONSE CURVE

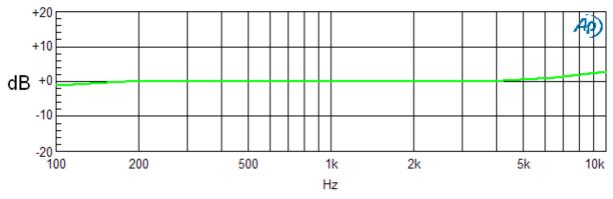
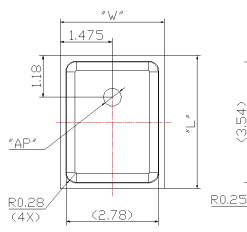
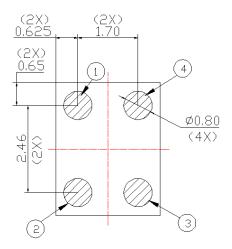


Figure 1. Typical free field frequency response (Normalized to 1 KHz)

″H″

5. MECHANICAL SPECIFICATIONS





ITEM	DIMENSION	TOLERANCE	UNITS
LENGTH(L)	3.76	± 0.10	mm
WIDTH(W)	2.95	± 0.10	mm
HEIGHT(H)	1.10	± 0.10	mm
ACOUSTIC PORT(AP)	φ 0.50	±0.10	mm

PIN OUTPUT		
PIN#	FUNCTION	
1	POWER(Vdd)	
2	GROUND	
3	GROUND	
4	OUTPUT	

Note:

Dimensions are in millimetres unless otherwise specified. Tolerance ± 0.15 mm unless otherwise specified

Figure 2. Detailed mechanical drawings

Wuxi NeoMEMS Technologies, Inc.



6. RECOMMENDED CUSTOMER LANDING PATTERN

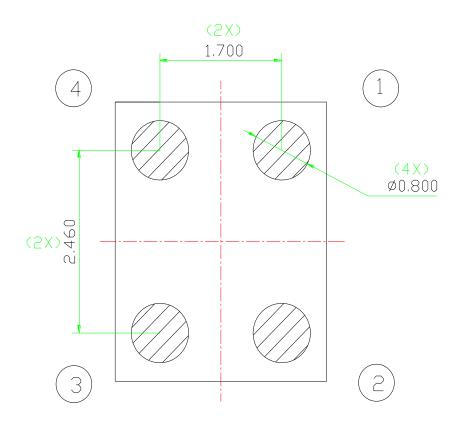


Figure 3. Recommended landing pattern on customers' PCB

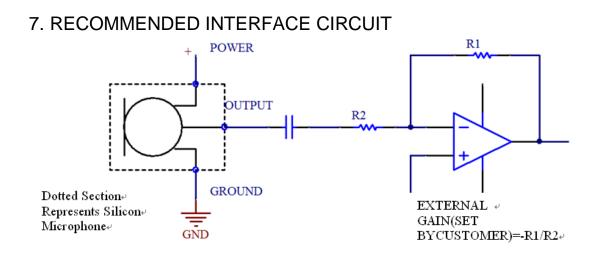
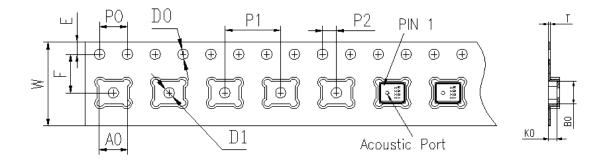


Figure 4. Recommended interface circuit for customers' applications

Wuxi NeoMEMS Technologies, Inc.



8. PACKAGING SPECIFICATIONS



D0	1.5±0.10	W	12.0±0.30
D1	1.5 ± 0.10	Е	1.75±0.10
A0	4.06±0.10	F	5.50±0.10
B0	3.30±0.10	P0	4.00±0.10
K0	1.35 ± 0.10	P1	8.00 ± 0.10
Т	0.3±0.05	P2	2.00±0.10

Notes:

(1) Tape & Reel Per EIA-481 standard;

(2) Label applied to external package and direct to reel

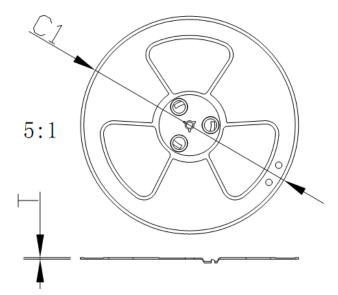
Order Part Number	Reel Diameter	Qty per Reel
NSM0402AT-LL	13"	5,000

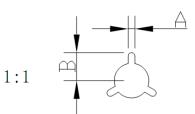
Figure 5. Tape Specification

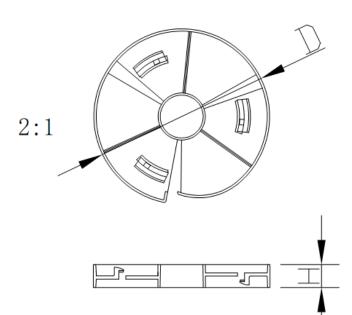
Wuxi NeoMEMS Technologies, Inc.



NeoMEMS Technologies, Inc.







SPEC	13"
C1±1.0	Ф330
A±0.2	2.6
$B\pm0.2$	10.8
T±0.2	2.0

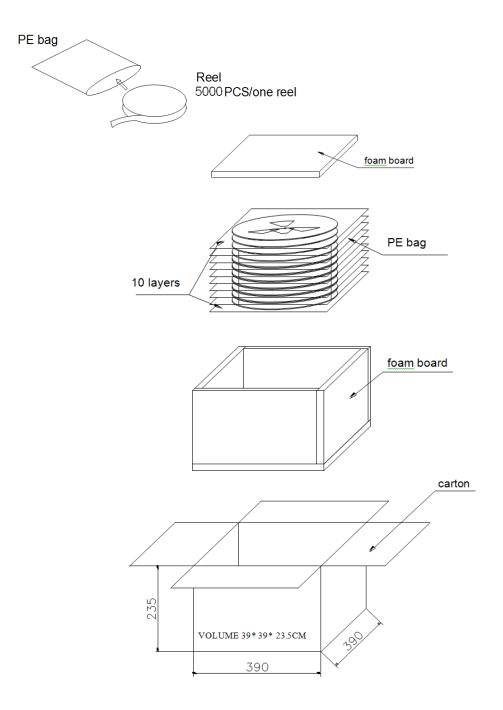
Avaliable Reel Size(mm)			
Tape Width $D \pm 0.5$ H+1			
12	Φ100	12.5	

5,000PCS PRODUCTS/1 reel

Figure 6. Reel Specification

Wuxi NeoMEMS Technologies, Inc.





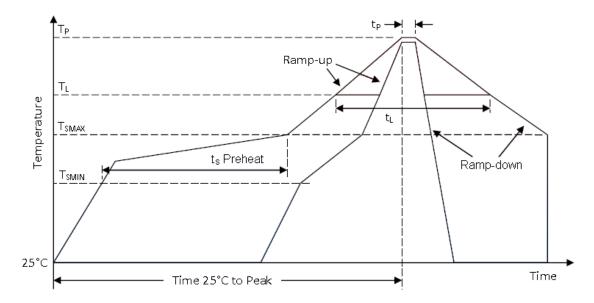
50,000 Pieces of Products per Carton

Figure 7 Packaging Specification

Wuxi NeoMEMS Technologies, Inc.



9. SOLDER REFLOW PROFILE



Profile Feature	Pb-Free
Average Ramp-up rate $(T_{SMAX} \text{ to } T_P)$	3°C/second max.
$\begin{array}{c} \text{Preheat} \\ \text{Temperature Min } (T_{\text{SMIN}}) \\ \text{Temperature Max } (T_{\text{SMAX}}) \\ \text{Time } (T_{\text{SMIN}} \text{ to } T_{\text{SMAX}}) (t_{\text{S}}) \end{array}$	150℃ 200℃ 60-180 seconds
Time maintained above: Temperature (T _L) Time (t _L)	217℃ 60-150 seconds
Peak Temperature (T _P)	260°C
Time within 5 $^{\circ}$ C of actual Peak Temperature (t _P)	20-40 seconds
Ramp-down rate(T_P to T_{SMAX})	6°C/second max
Time 25°C to Peak Temperature	8 minutes max

Figure 8 Recommended leadless solder reflow temperature profile

Notes:

- 1. Vacuuming over acoustical hole of the microphone is not allowed, because the Devices can be damaged by vacuum.
- 2. Washing the board after reflow process is not allowed, because board washing and Cleaning agents can damage the device. A device should not be exposed to ultrasonic processing or cleaning.
- 3. Recommended number of reflow is no more than 5 times.

Wuxi NeoMEMS Technologies, Inc.



10. RELIABILITY SPECIFICATIONS

Test item	Detail	Standard
Reflow Simulation	Refer to Sec.9 for solder reflow profile, total 5 times	/
Low Temperature Bias	Conditions:-40°C Duration:168 hours while under bias	IEC 60068-2-2 Test Aa
High Temperature Bias	Conditions: 105°C Duration:168 hours while under bias	IEC 60068-2-2 Test Ba
Thermal Shock	Conditions: 100 cycles of air-air thermal shock from -40 °C to 125 °C with 15-minute soaks	IEC 60068-2-4
Temperature/Humidity Bias	Conditions: 85 °C /85%RH environment while under bias for 168 hours	JESD 22-A101A-B
Mechanical Shock	Conditions:3 pulses of 10,000g in the X,Y and Z direction	IEC 60068-2-27 Test Ea
Vibration Test	Test axis: X,Y,Z Conditions: 2~400Hz 1 oct/min Test time: 15 mins per axis Use fixture during the testing	IEC 60068-2-6
Drop Test	Conditions: For each sample, drop by all corners, edges, surfaces respectively. Steel floor. Drop height: 1800mm.	IEC 60068-2-32
ESD	Conditions: \pm 8KV direct contact to the lid when unit is grounded , \pm 4KV direct contact to the I/O pins.10 times	IEC 61000-4-2

Note: Immediately after reliability test, the samples shall be stored under climatic conditions such as that normally exist in ordinary rooms or laboratories. Unless otherwise noted, the recovery period shall be 2 hours at least before performance testing. After test condition is performed, the sensitivity of the microphone shall not deviate more than 3dB from its initial value.

Wuxi NeoMEMS Technologies, Inc.



11. REVISION HISTORY:

Version	Date	Description
1.0	12/12/2013	Initial release

Disclaimer: The information contained in this literature is based on our experience to date and is believed to be reliable and it is subject to change without notice. It is intended as a guide for use by persons having technical skill at their own discretion and risk. We do not guarantee favorable results or assume any liability in connection with its use. Dimensions contained herein are for reference purposes only. For specific dimensional requirements consult factory. This publication is not to be taken as a license to operate under, or recommendation to infringe any existing patents. This supersedes and voids all previous literature.

Wuxi NeoMEMS Technologies, Inc.

The above information is the exclusive intellectual property of Wuxi NeoMEMS Technologies, Inc. and shall not be disclosed, distributed or reproduced without permission from Wuxi NeoMEMS Technologies, Inc.